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*Published in:*
ACStm Applied Materials & Interfaces

*DOI:*
10.1021/acsami.0c09255

*Published:*
19/08/2020

*Document Version:
Publisher's PDF, also known as Version of record

*Published under the following license:
Other

*Please cite the original version:

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Freestanding and Supported MoS₂ Monolayers under Cluster Irradiation: Insights from Molecular Dynamics Simulations

Sadegh Ghaderzadeh,* Vladimir Ladygin, Mahdi Ghorbani-Asl, Gregor Hlawacek, Marika Schleberger, and Arkady V. Krasheninnikov*

ABSTRACT: Two-dimensional (2D) materials with nanometer-size holes are promising systems for DNA sequencing, water purification, and molecule selection/separation. However, controllable creation of holes with uniform sizes and shapes is still a challenge, especially when the 2D material consists of several atomic layers as, e.g., MoS₂, the archetypical transition metal dichalcogenide. We use analytical potential molecular dynamics simulations to study the response of 2D MoS₂ to cluster irradiation. We model both freestanding and supported sheets and assess the amount of damage created in MoS₂ by the impacts of noble gas clusters in a wide range of cluster energies and incident angles. We show that cluster irradiation can be used to produce uniform holes in 2D MoS₂, with the diameter being dependent on cluster size and energy. Energetic clusters can also be used to displace sulfur atoms preferentially from either top or bottom layers of S atoms in MoS₂ and also clean the surface of MoS₂ sheets from adsorbents. Our results for MoS₂, which should be relevant to other 2D transition metal dichalcogenides, suggest new routes toward cluster beam engineering of devices based on 2D inorganic materials.

KEYWORDS: two-dimensional materials, MoS₂, cluster irradiation, pore formation, sputtering yield, atomistic simulations

INTRODUCTION

After nearly 2 decades since the first exfoliation of individual sheets from graphite and inorganic compounds with a layered structure,1 two-dimensional (2D) materials continue to surprise us, as more and more potential applications of these systems are revealed.2 In particular, creating nanoscale pores in these atomically thin impervious membranes and using the holey material for DNA sequencing, water purification, separation of chemical species, etc. has been suggested.3−8 This should allow us to develop a new generation of DNA and complex protein sequencers with unprecedented speed, precision, and low cost, which may revolutionize genomic medicine.5−8 As for particle selection/separation, having nanopores of the right sizes in 2D materials allows only the desired ions/molecules to pass through the pores and block unwanted particles.3,4

It is intuitively clear that the precise control over the sizes of the pores is the key to the successful use of 2D materials in these applications. Various techniques can be employed to perforate graphene and inorganic 2D materials such as h-BN or transition metal dichalcogenides (TMDs). Among them, lithographic patterning using block copolymers,9 positive e-beam resist,10 and other mask materials have been used to create periodic arrays of holes in graphene, the so-called nanomesh, which is interesting in the context of tuning the electronic properties of the system. However, these techniques provided holes with diameters of tens of nanometers, which may be too large for, e.g., molecule separation. Preparation of holey graphene via catalytic oxidation11 has also been reported, but controlling the uniformity of hole sizes and shapes is a challenge.

Another group of methods to produce holes in 2D systems relies on applying beams of energetic particles, ions and electrons, and changing the atomic structure of the target material by ballistically displacing the atoms.12−14 In particular, electron irradiation in the transmission electron microscope (TEM) has been demonstrated to produce holes with diameters of few nanometers in graphene,1,5−8 h-BN,19,20 and TMDs.21−23 Although the electron beam in a scanning TEM can nowadays be focused into a sub-angstrom area, potentially providing unprecedented control over the sizes and shapes of the holes, this technique cannot be scaled up to produce enough material even at the tens-of-micrometer scale. Ion irradiation has successfully been used to create defects in various 2D materials14,24−26 or directly implant dopants. However, impacts of individual ions with most easily accessible low charge states and moderate energies produce predom-
inantly single vacancies and small vacancy clusters and not holes with diameters of few nanometers. Besides, irradiation in this case gives rise to the formation of defects with different sizes. Focused ion beams, especially in the He-ion microscope (HIM), have been demonstrated to be suitable for patterning various 2D materials and creating pores, but the main drawback of this approach is the collateral damage to the material close to the holes due to the spread of the beam and, in the case of supported materials, due to the ions backscattered from the substrate. Swift heavy ions can produce larger holes in semiconducting 2D materials and even in semimetallic graphene either supported or free-standing, once the electronic stopping exceeds a certain threshold value, but the availability of such facilities is limited.

Using highly charged but relatively slow ions is another approach to perforate 2D materials. In this case, the charge state of the incident ion is the parameter that controls the potential energy stored in the ion and allows additional energy to be deposited into the target, so that ions with higher charge states produce larger pores. Highly charged ions have been successfully used to create pores with controllable diameters of a few nanometers in 2D MoS2. For low charge states, the size distribution of these pores turned out to be rather small (full width at half-maximum (FWHM) = 0.75 nm), whereas for higher charge states, it quickly increased to larger values (FWHM = 1.75 nm). The pore shapes were generally round, but more irregular shapes with jagged edges were also frequently found.

A more uniform distribution of the hole sizes may be achieved, however, using cluster irradiation, as, contrary to single-ion impacts, the outcome of collision weakly depends on the impact point, as clusters are normally larger than the primitive cell size of the material. Atomic simulations of cluster impacts onto graphene and polycrystalline boron nitride nanosheets indicate that the size of the hole correlates well with the size of the cluster and indeed pore diameters are more uniform. These simulations have been carried out for truly single-layer structures, and it is not obvious how this approach works for 2D materials, which, e.g., TMDs, consist of several atomic layers. Besides, mostly freestanding 2D materials have been studied, while the substrate can completely govern defect production and annealing in supported 2D materials.

In this article, using analytical potential molecular dynamics (MD) simulations, we study the response of MoS2 sheets, both freestanding and supported by a SiO2 substrate, to cluster irradiation. MoS2, which consists of three atomic layers, is the archetypal TMD material. Besides, holey MoS2 is expected to be efficient for gas separation and water desalination. We consider impacts of clusters of various noble gas atoms (Ne, Ar, Kr, and Xe) in a wide range of energies. Note that by using noble gas clusters, chemical reactions between the cluster and target atoms are avoided. We model both normal and grazing trajectories, as the latter can be used to displace sulfur atoms predominantly from one side of the sheet, and, followed by the deposition of other chemical elements, e.g., Se, manufacture the so-called Janus structures, tuning thus the electronic properties of the material. Off-normal cluster irradiation can also be employed for cleaning the surface of MoS2 from ubiquitous hydrocarbons or removing small flakes of the same material, effectively smoothing the surface, similar to bulk systems, provided that the threshold value for producing defects in the material is not exceeded.

### COMPUTATIONAL DETAILS

To get insights into the interaction of the energetic clusters of noble gas atoms with MoS2 sheets, we performed analytical potential molecular dynamics (MD) simulations using the LAMMPS computational package as detailed below.

#### Simulation Setup.

The simulation setups for the cluster ion irradiation of freestanding and supported MoS2 monolayers are shown in Figure 1a,b, respectively. The atomic geometry of the monolayers was initially optimized using the analytical potentials described below. The target systems were then irradiated with noble gas clusters. The initial (absolute) temperature of the system was zero, and periodic boundary conditions were employed.

The outermost atomic layers were kept fixed during irradiation simulations, as schematically shown in Figure 1c, so that the entire system was not displaced under cluster impacts. To avoid the spurious reflection of heat and pressure waves from the borders of the system, the velocities of the atoms were scaled down in the border areas using the Berendsen thermostat, thus mimicking the energy dissipation in an infinitely large sheet. In fact, three thermostat regions near the supercell boundaries were defined, each with different dissipating powers to precisely dissipate the outgoing energy waves. Free MD was carried out in the central region.

Incident noble gas atom clusters Mn, where M is Ne, Ar, Kr, and Xe and N is the number of atoms, were constructed using the Wulff method, where each cluster has three main facets (\{100\}, \{110\}, and \{111\}). As the orientation of these nonspherical clusters may affect the damage production, in the MD simulations we used three different orientations of the clusters and averaged over them. In the size-dependent simulations, cluster radii varied from 10 to 50 Å, and correspondingly the number of atoms from \(N = 135\) to 15 779. When assessing the effects of incident angle and energy of the cluster, we chose \(N = 79\) due to its “regular” geometry and correspondingly higher stability. The \(N = 79\) clusters...
composed from different noble gas atoms are shown in Figure 1d.

The incident cluster energies were in the range of 1–1000 eV/atom, and the incident polar angles varied from normal to grazing (i.e., from 0 to ~80°). As nuclear stopping is much higher (by a factor of 5–10, depending on the projectile51) in this energy range than electronic stopping for the atoms involved in the simulations, we fully disregarded the latter. After cluster impact simulations as described above and reaching a dynamical equilibrium in the central area, the system was quenched to 0 K. The charge state of the cluster cannot be accounted for in the analytical potential MD simulations so that the clusters were assumed to be neutral. As cluster energies we considered are rather small (the corresponding cluster velocities are smaller than the Fermi velocity in MoS252), one can expect that this approximation did not affect the results, as in the experiment, the clusters should also be neutral upon reaching MoS2 because of the charge exchange that would take place before the impact.

The sizes of the clusters used in our study are much larger than the primitive cell size of MoS2, implying that the outcome of a collision should not be very sensitive to the choice of the impact point defined as the intersection of the cluster center-of-mass trajectory with the topmost plane of target atoms. Nonetheless, we sampled over the impact points in the irreducible area in the MoS2 primitive cell53 and averaged the results. Twelve impacts per cluster-rotations per irreducible-area, i.e., 36 impacts for each set of parameters (energy, angle, atom-type), were modeled.

The substrate in this work was chosen to be a SiO2 slab, whose thickness was adjusted depending on cluster energy. Due to the small penetration depth of the incident cluster into the target, atomistic simulations of the actual substrate, instead of the previously used potential-region models, were feasible. Energy dissipation was also implemented at the boundaries of the substrate.

The simulation time, including quenching the system after the impacts, were up to 80 ps. Test simulations with longer times gave essentially the same results. An adaptive time-step method for impact simulations has been used as implemented in LAMMPS.

The area of nanopores produced by cluster impacts was evaluated using the same approach as employed previously39 to determine pore sizes created after impacts of single ions. In practice, the coordinates of all atoms are projected onto an X–Y plane. In each position, a Gaussian function is introduced to define atom density. Using a certain threshold value, we search for the area with a smaller density, which points to the presence of a pore in the system. When we find the pore, we count the number of missing grid points in the pore area and transform these grid points into the pore size.

Interatomic Potentials. Five different elements (noble gas atom plus two target and two substrate atoms) were involved in every simulation, each of which interacts with its own type and also with the other elements. The used interatomic potentials are reactive empirical bond order (REBO) potential,54 Tersoff,55 Lennard-Jones (LJ),56 and the Ziegler–Biersack–Littmark (ZBL)57 potentials. To describe the interaction of atoms at small separations, the REBO and Tersoff potentials were splined to the ZBL potential at short atomic distances. The interactions between Mo−Mo, S−S, and Mo−S were modeled by the REBO−ZBL potential, and Tersoff−ZBL was employed to describe the Si−Si, O−O, and Si−O interactions. The choice of the potential for MoS2 was motivated by a very good reproduction (as compared to other potentials available for this material) of defect formation energies obtained using first-principles calculations.53 The interactions between the cluster elements (Ne, Ar, Kr, and Xe) with themselves as well as Mo−Si, Mo−O, S−Si, and S−O interactions were described by the LJ potential. All of the LJ parameters used in this work58–65 are listed in Table 1. The LJ potentials were not splined to the ZBL potentials, as for the atom pairs and the energy range (10–1000 eV/atom) considered in our work, the LJ potential, which behaves as 1/R12 at small separations, is more repulsive than the ZBL potential. Thus, splining ZBL to the LJ potential is technically more difficult and sometimes not even possible, as splining can either affect the lowest energy configuration or give rise to unphysical “humps” on the energy vs distance curves. Moreover, the analysis of interatomic distances during the impacts for the atom pairs described by the LJ potential indicated that for atoms in the energy range below 50 eV the difference between LJ and ZBL is rather small. Note also that we are primarily interested in the development of damage in the MoS2 target, while the interactions described by the LJ potentials are not between Mo and S but other atoms, e.g., noble gas atoms or atoms sputtered from the target and substrate atoms. The interactions of the elements constituting the clusters (Ne, Ar, Kr, and Xe) with Mo, S, Si, and O atoms were assumed to be purely repulsive and therefore were treated with the ZBL potential.

RESULTS AND DISCUSSION

Figures 2 and 3 present snapshots of the atomic structure from the MD simulations of a cluster impact onto a freestanding and supported MoS2 sheet, respectively. The front sides of the structures were made partly transparent to make the atomic structure at the impact point visible. It is evident that the response of the systems is quite different, e.g., a high forward sputtering for the freestanding material is observable, while the substrate “stops” the atoms and also gives rise to the development of a larger pressure wave due to the backscattered atoms. Taking this into account, we studied the response of suspended and supported MoS2 sheets separately and then compared the results.

Freestanding MoS2 Sheets. One can expect that controllable pore creation in MoS2 under cluster ion irradiation can be achieved via tuning the following four parameters: element type, cluster size, incident energy, and incident angle. To assess the role of each parameter, we varied one of them while keeping the others fixed.

Table 1. Parameters of the Lennard-Jones (LJ) Potentials Used in This Workab

<table>
<thead>
<tr>
<th>interaction type</th>
<th>ε</th>
<th>σ</th>
</tr>
</thead>
<tbody>
<tr>
<td>Mo−Si</td>
<td>0.00652</td>
<td>3.274</td>
</tr>
<tr>
<td>Mo−O</td>
<td>0.00251</td>
<td>2.920</td>
</tr>
<tr>
<td>S−Si</td>
<td>0.01439</td>
<td>3.721</td>
</tr>
<tr>
<td>S−O</td>
<td>0.00558</td>
<td>3.385</td>
</tr>
<tr>
<td>Ne−Ne</td>
<td>0.002947</td>
<td>2.865</td>
</tr>
<tr>
<td>Ar−Ar</td>
<td>0.0103</td>
<td>3.45</td>
</tr>
<tr>
<td>Kr−Kr</td>
<td>0.014391</td>
<td>3.670</td>
</tr>
<tr>
<td>Xe−Xe</td>
<td>0.019156</td>
<td>4.10</td>
</tr>
</tbody>
</table>

“aThe LJ cutoffs are 2.5 times σ. |
Response of MoS₂ to Cluster Irradiation: The Dependence on Cluster Energy. We considered first the normal incidence of the clusters. Having carried out the MD simulations as described above, we analyzed the final atomic configuration and calculated the sputtering yield as a function of the incident energy of the cluster. The examples of the atomic structures are presented in Figure 4. Each structure is presented in the final configuration after quenching the kinetic energy of the atoms to zero. It is evident that there is an energy threshold for sputtering, as only above a certain cluster energy holes are formed. Similar results were obtained for other noble gases.

The sputtering yield was defined as the total number of atoms sputtered from the system after a single impact. We also evaluated separately the number of S atoms sputtered from the top ($S_{\text{top}}$) and bottom ($S_{\text{bottom}}$) layers and also the number of Mo atoms. The results are presented in Figure 5 for various noble gases. The energy threshold for sputtering yield is $\sim 5$ eV/atom for Ne and is slightly higher $\sim 6$ to 7 eV/atom for heavier noble gas atoms. The damage production increases first quickly with cluster energy and then the growth becomes much slower when holes are formed.

While heavier elements sputter more atoms at energies above $\sim 20$ eV/atom, the lighter ones (Ne) sputter more atoms at lower energies. This behavior becomes clear when one looks at the sizes of the clusters of different types when containing the same number of atoms (Figure 1d). The heavier clusters have larger diameters due to the larger sizes of the atoms and correspondingly longer interatomic distances. Therefore, the energy transfer per target area for the lighter elements, due to their smaller sizes, is higher and the clusters create more damage at low energies. At low/moderate energies, the higher sputtering yield of $S_{\text{bottom}}$ atoms under Ar cluster irradiation is due to the fact that the masses of Ar and S are comparable, which leads to the maximum energy transfer in comparison to other cluster elements, as evident from the head-on binary collision energy transfer formula: $E_{\text{trans}} = E_p \times 4m_p m_t/(m_p + m_t)^2$, where $E_{\text{trans}}$ is the maximum transferred energy in a binary collision, $m_p$ and $m_t$ are the masses of the projectile and target atoms, respectively.
target atoms, respectively, and $E_p$ is the projectile kinetic energy. We stress that the development of damage under cluster impacts is a complicated process, so that the above simple arguments, which help to understand the main trends, should be considered with caution. At high energies, the defect production is governed by the cluster size, and not the energy transfer, followed by its redistribution in the system, as target atoms in the impact area get enough momentum to immediately leave the system and the additional transferred energy is carried away by the sputtered atoms.

The total sputtering yield and the radii of the created pores are shown in Figure 6a,b, respectively, as functions of the incident ion energy. To compensate for the irregular shape of the pores, the diameter of the pores is calculated from the pore area, assuming roughly circular pores (see Figure 4 for the examples). The pore radius—incident energy curve demonstrates a qualitatively similar behavior as the sputter yield—energy relation. There are small differences at intermediate energies, though, when the sputtered atoms with low kinetic energies are unable to leave the system and eventually are reattached to the target elsewhere. Likewise, at low energies and under impacts of lighter clusters, there might be sputtered atoms from only one layer of S atoms, but no pore is created.

**Dependence of Defect Production on Angle of Incidence.**

We also studied the effects of the incident angle of the cluster on defect production. Zero value of the angle corresponds to normal incidence. We chose three different values of cluster incident energies (10, 50, and 100 eV/atom) and calculated sputtering yields as a function of incident angle for different noble gases. The results of the calculations are shown in Figure 7. For 10 eV/atom, no atom is sputtered at angles above $\sim 60^\circ$, while the clusters with higher energies sputter target atoms up to $\sim 80^\circ$. The lighter clusters (Ne and Ar) cause more damage at small incident angles at low and intermediate cluster energies, which originates from their smaller sizes, as discussed in the Response of MoS$_2$ to Cluster Irradiation: The Dependence on Cluster Energy section. However, at higher energies, the sputtering yield under the impacts of lighter clusters decays faster with angle. For the freestanding system, more S atoms are always sputtered from the bottom layer, as atoms in the upper MoS$_2$ layers get pushed and transfer their gained momentum to the atoms in the bottom layers.

![Figure 6](image1.png)

**Figure 6.** Total sputtering yield from a freestanding MoS$_2$ sheet (a) as well as the induced pore radius (b) under normal impacts of clusters having 79 noble gas atoms of different types.

![Figure 7](image2.png)

**Figure 7.** Sputtering yields as a function of the incident angle. (a) Cluster energies are 10 and 50 eV/atom, and the corresponding curves are plotted with different background colors. (b) Cluster energy is 100 eV/atom.

![Figure 8](image3.png)

**Figure 8.** Sputtering yield (a) and pore radius (b) as functions of cluster radius for freestanding MoS$_2$ under normal impacts of Xe and Ar clusters. The incident energy is 100 eV/atom.
Although the dependence of the sputtering yield on cluster energy is weak around 100 eV/atom for normal incidence, this dependence remains strong for large angles (e.g., at ∼60°; Figure 7). This behavior can be understood in terms of the extended impact area of the cluster at high angles, given that the incident energy is high enough to cause damage. In other words, contrary to the normal incidence where the sputtered or noble gas atoms leave the target while they still have substantial energy, the particle at a larger angle has more atoms ahead to transfer its energy to, and hence to cause more damage.

At even larger angles corresponding to grazing trajectories, the cluster atoms interact with a larger number of target atoms, as presumed in the channeling models, instead of the atoms in the cluster-size impact area. Further increase in the incident angle results in a situation where the cluster “sees” the infinite plane of atoms so that sputtering is not possible.

Effects of Cluster Size. To assess the role of the cluster size, we carried out simulations for Ar and Xe clusters, representing medium-mass and high-mass elements. The incident angle was normal, and the cluster energy was chosen to be 100 eV/atom, the regime in which the number of sputtered atoms depends rather weakly on cluster energy, Figure 5. Sputtering yield and radius of the induced pores are plotted against the corresponding cluster radius in Figure 8, panels a and b, respectively. Pore radius depends nearly linearly on the cluster radius, implying that by simply tuning the cluster size, it should be possible to control the size of the pore. We stress that the standard deviation of the pore radius is very small, less than 5%, which indicates that the creation of pores with uniform diameters can be achieved in the experiment.

Note that although the majority of the sputtered atoms in the freestanding case are displaced downward, S atoms in the top layer are occasionally sputtered upward. This behavior may initially seem counterintuitive, but the S atoms are in fact supported by the heavy Mo layer, so that S atoms may be reflected by Mo atoms. There are even rare cases where the Mo atoms are also among the atoms sputtered upward. These upward-moving Mo atoms however are never found as isolated atoms but always accompanied by S atoms.

Supported MoS₂ Sheets. Having analyzed the response of freestanding MoS₂ to cluster irradiation, we moved on to the supported sheets. We carried out simulations similar to the freestanding case but limited noble atom types to Xe due to a much higher computational cost of these simulations.

Response of Supported MoS₂ to Cluster Irradiation: The Role of Cluster Energy. Sputtering yield upon impacts of Xe clusters from a supported MoS₂ sheet is presented in Figure 9a as a function of cluster energy. The results for the freestanding material are also given. A comparison of the responses of freestanding and supported MoS₂ layers to cluster irradiation indicates a clear influence of the substrate on damage production. The difference is substantial at both low and high energies as previously reported for single ions. At low energies, the downward sputtering of target atoms is partly suppressed by the substrate. In the high-energy case, where the freestanding MoS₂ membrane stays almost still after the collision, at low cluster energies the MoS₂ membrane swings up and down. However, when supported, the substrate does not allow it to swing. The substrate not only prevents sputtering from the bottom but also takes some of the incident shock energy and dissipates it.
The sputtering of bottom S atoms from the freestanding MoS₂ is always dominant, but in the supported sheets, a part of their kinetic energy may be transferred to the top atoms due to the reflection of recoils by the substrate atoms, enhancing the $S_{	ext{up}}$ sputtering. At high energies, sputtering yield is higher in the supported system. The analysis of atom trajectories indicates that the sheet is damaged by the reflected atoms and atoms sputtered from the substrate, giving rise to the formation of larger holes, as is evident from Figure 9b. One can expect, though, that at high energies exceeding those studied in our work, the pore size should also weakly depend on cluster energy, as the energy will mostly be deposited in the substrate. The standard deviation of the pore radius is also very small, similar to the freestanding system, which indicates that creation of pores with uniform diameters can be experimentally achieved also for supported MoS₂.

The number of sputtered atoms and correspondingly the diameter of the created pores can be noticeably larger than the cluster size, especially for large clusters and at high cluster energies. A snapshot of the impact of a Xe cluster with a diameter of 30 Å onto the supported system is shown in Figure 10c, along with the initial and final atomic configurations for the freestanding system (Figure 10a,b). The size of the pore in the freestanding case is comparable with the cluster size, while for the supported system it (Figure 10c) is considerably larger.

We were unable to systematically study the dependence of pore sizes on cluster diameters as the computational cost of MD simulations increases with the number of atoms, so that collecting statistics for the collisions of big clusters with the supported 2D MoS₂ is computationally very demanding (note that not only the MoS₂ sheet but also the substrate must be large). However, one can expect that the trend is the same as for the freestanding system: the pore size is proportional to the cluster diameter (but is noticeably larger).

**Supported MoS₂ under Cluster Impacts: The Effects of Incident Angle.** The effects of cluster incident angle on defect and pore creation in supported MoS₂ were investigated with the cluster energies being fixed to 10, 50, and 100 eV/atom. The results of the simulations are presented in Figure 11. It is evident that the presence of a substrate gives rise to the suppression of sputtering at low (10 eV/atom) cluster energy, essentially creating no damage. In the intermediate regime (50 eV/atom), more atoms are sputtered from the top of the MoS₂ sheet for the same cluster energy and angle of incidence than for the freestanding case and the other way around for the bottom layer. The reason for this is discussed in the previous Response of Supported MoS₂ to Cluster Irradiation: The Role of Cluster Energy section: the substrate stops the atoms sputtered from the bottom layer and increases sputtering from the top due to backscattered and recoil atoms. The behavior of the system at high cluster energies (100 eV/atom) is the same as in the intermediate regime. The effect of the substrate is very weak at grazing trajectories when the perpendicular momentum component is very small so that the substrate is not involved, and the overall trend is similar to the freestanding case.

**CONCLUSIONS**

Using analytical potential MD simulations, we studied the response of MoS₂ sheets, both freestanding and supported by a SiO₂ substrate, to noble gas cluster irradiation. Impacts of clusters with both normal and grazing trajectories composed from various noble gas atoms (Ne, Ar, Kr, and Xe) in a wide range of energies were considered. Our results indicate that when cluster energy is above 20 eV/atom, cluster irradiation can be used to produce pores in 2D MoS₂ sheets, with a diameter depending on the cluster size. For supported MoS₂ sheets, the diameter also depends on cluster energy, while it is essentially independent of cluster energy for the freestanding system (above 100 eV/atom). In both cases, the statistical distribution of the pore diameters is much more uniform as compared to pores created by single ions. This is related to a much larger “effective” impact area and correspondingly a weaker dependence of the collision outcome on the impact parameter. We further showed that energetic clusters can also be used to displace sulfur atoms preferentially from the top or the bottom layer of S atoms in supported MoS₂, which, using subsequent deposition of other chemical elements, can be employed to engineer Janus structures, similar to plasma treatment. These structures allow the tuning of the electronic properties of the material. As no damage is created in MoS₂ sheets at angles exceeding the critical angle (~40° for the supported and ~60° for the freestanding system) and low (~10 eV/atom) energies, cluster irradiation could be used to clean the surface of MoS₂ sheets from adsorbents. Our results for MoS₂, which is the archetypical TMD material, should also be relevant to other members of the TMD family and may suggest new routes toward cluster beam engineering of devices based on 2D inorganic materials and their applications in DNA sequencing, water purification, and molecule separation.

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The atomic visualizations are created using the Open Visualization Tool (OVITO). The computational support from the Technical University of Dresden computing cluster (TAURUS) and from High-Performance Computing Center (HLRS) in Stuttgart, Germany, directly and also through PRACE project 2018184458 are gratefully appreciated. The structures are generated using the methods implemented in VirtualNanoLab (VNL). This work is part of the npSCOPE project and has received funding from the European Union’s Horizon 2020 research and innovation program (grant no. 720964). We also thank the DFG for support within the projects SCHL 384/20-1 (project no. 406129719) and KR 4866/2-1 (project no. 406129719).

**ACKNOWLEDGMENTS**

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**Notes**

The authors declare no competing financial interest.

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